Notice of References Cited Application/Control No. 10/822,960 Examiner Andy Huynh Applicant(s)/Patent Under Reexamination LEE ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-			
	В	US-			
	С	US-			
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	G	US-			
	Н	US-			
	ı	US-			
	J	US-			
	К	US-			
	L	US-	516		
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 63244748 A	10-1988	Japan	SUETAKE, MIKIO	
	0					
	Р					
	Q					
	R					
	s					
	Т					

NON-PATENT DOCUMENTS

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